Supporting Information

for

Tailoring the nanoscale morphology of HKUST-1 thin films via codeposition and seeded growth

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Additional experimental data

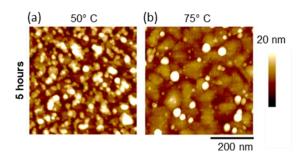


Figure S1: AFM images (500 nm \times 500 nm) of HKUST-1 surMOFs fabricated for 5 h via codeposition at (a) 50 °C and (b) 75 °C on SAM-coated Au surfaces. These images at a higher magnification than those shown in Figure 2 allow for the clear visualization of the nanoscale MOF crystallites. Both images were set to the same *z*-scale (20 nm).

Infrared spectroscopy: IR spectra collected from 3800–600 cm⁻¹ in the attenuated total reflectance (ATR) mode of a Thermo Scientific Nicolet iS50 instrument. The spectral resolution was 4 cm⁻¹ and a bare gold substrate was used as the background for the surMOF films.

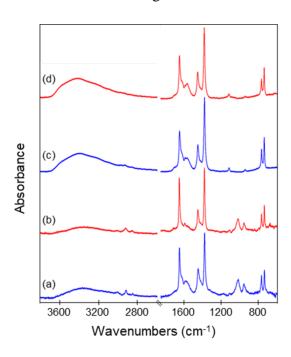


Figure S2: IR spectra of HKUST-1 surMOFs fabricated via codeposition (a) at 25 °C for 1.5 h and (b) at 50 °C for 5 h on SAM-coated Au surfaces. Four additional layers of HKUST-1 were added to these codeposited samples via layer-by-layer deposition. The subsequent IR spectra are shown in (c,d).